
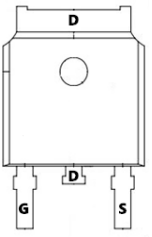


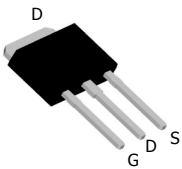
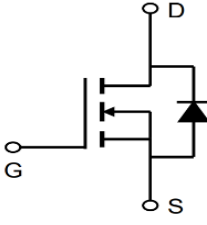
TM50N06YS

N-Channel Enhancement Mosfet

| | |
|--|--|
| <p>General Description</p> <ul style="list-style-type: none"> • Low $R_{DS(ON)}$ • RoHS and Halogen-Free Compliant <p>Applications</p> <ul style="list-style-type: none"> • Load switch • PWM | <p>General Features</p> <p>$V_{DS} = 60V$ $I_D = 50A$</p> <p>$R_{DS(ON)} = 13 m\Omega$ (typ.) @ $V_{GS} = 10V$</p> <p>100% UIS Tested 100% R_g Tested</p>  |
|--|--|



Y:TO-251S-3L

Marking: 50N06

Absolute Maximum Ratings ($T_A = 25^\circ C$ unless otherwise noted)

| Symbol | Parameter | Max. | Units |
|-----------------|---|---------------------|--------------|
| V_{DSS} | Drain-Source Voltage | 60 | V |
| V_{GSS} | Gate-Source Voltage | ± 20 | V |
| I_D | Continuous Drain Current | $T_C = 25^\circ C$ | 50 |
| | | $T_C = 100^\circ C$ | 23 |
| I_{DM} | Pulsed Drain Current ^{note1} | 180 | A |
| EAS | Single Pulsed Avalanche Energy ^{note2} | 280 | mJ |
| P_D | Power Dissipation | $T_C = 25^\circ C$ | 87.7 |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 1.6 | $^\circ C/W$ |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to +175 | $^\circ C$ |

Thermal Characteristic

| | | | |
|--|-----------------|------|--------------|
| Thermal Resistance, Junction-to-Case ^(Note 2) | $R_{\theta JC}$ | 1.76 | $^\circ C/W$ |
|--|-----------------|------|--------------|

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|---|--------------|--|-----|------|-----------|------------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS}=0V, I_D=250\mu A$ | 60 | - | - | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=60V, V_{GS}=0V$ | - | - | 1 | μA |
| Gate-Body Leakage Current | I_{GSS} | $V_{GS}=\pm 20V, V_{DS}=0V$ | - | - | ± 100 | nA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=250\mu A$ | 1.0 | 1.6 | 2.5 | V |
| Drain-Source On-State Resistance | $R_{DS(ON)}$ | $V_{GS}=10V, I_D=30A$ | - | 13 | 16 | m Ω |
| Forward Transconductance | g_{FS} | $V_{DS}=5V, I_D=30A$ | 30 | - | - | S |
| Dynamic Characteristics (Note 4) | | | | | | |
| Input Capacitance | C_{iss} | $V_{DS}=25V, V_{GS}=0V,$ $F=1.0MHz$ | - | 2498 | - | PF |
| Output Capacitance | C_{oss} | | - | 185 | - | PF |
| Reverse Transfer Capacitance | C_{rss} | | - | 80 | - | PF |
| Switching Characteristics (Note 4) | | | | | | |
| Turn-on Delay Time | $t_{d(on)}$ | $V_{DD}=30V, I_D=2A, R_L=1\Omega$ $V_{GS}=10V, R_{GEN}=3\Omega$ | - | 12 | - | nS |
| Turn-on Rise Time | t_r | | - | 5.2 | - | nS |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 38 | - | nS |
| Turn-Off Fall Time | t_f | | - | 27 | - | nS |
| Total Gate Charge | Q_g | $V_{DS}=30V, I_D=30A,$ $V_{GS}=10V$ | - | 36 | - | nC |
| Gate-Source Charge | Q_{gs} | | - | 9.9 | - | nC |
| Gate-Drain Charge | Q_{gd} | | - | 6.6 | - | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage (Note 3) | V_{SD} | $V_{GS}=0V, I_S=30A$ | - | - | 1.2 | V |
| Diode Forward Current (Note 2) | I_S | | - | - | 50 | A |
| Reverse Recovery Time | t_{rr} | $T_J = 25^\circ\text{C}, I_F = 30A$ $di/dt = 100A/\mu s$ (Note 3) | - | 35 | | nS |
| Reverse Recovery Charge | Q_{rr} | | - | 47 | | nC |
| Forward Turn-On Time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production
5. E_{AS} condition: $T_J=25^\circ\text{C}, V_{DD}=30V, V_G=10V, L=0.5mH, R_g=25\Omega$

Typical Performance Characteristics

Figure 1: Output Characteristics

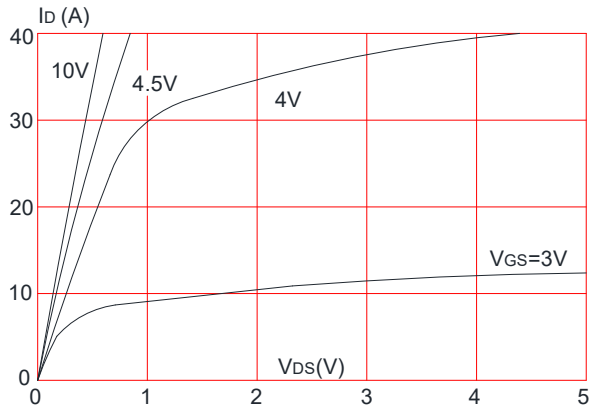


Figure 2: Typical Transfer Characteristics

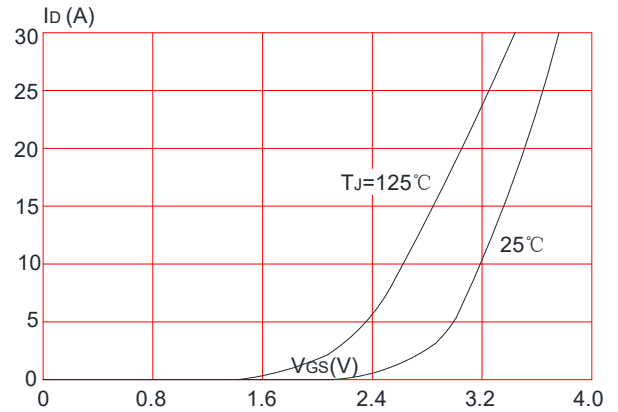


Figure 3: On-resistance vs. Drain Current

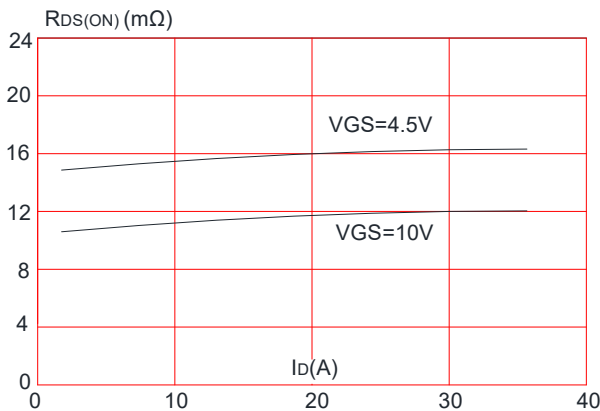


Figure 4: Body Diode Characteristics

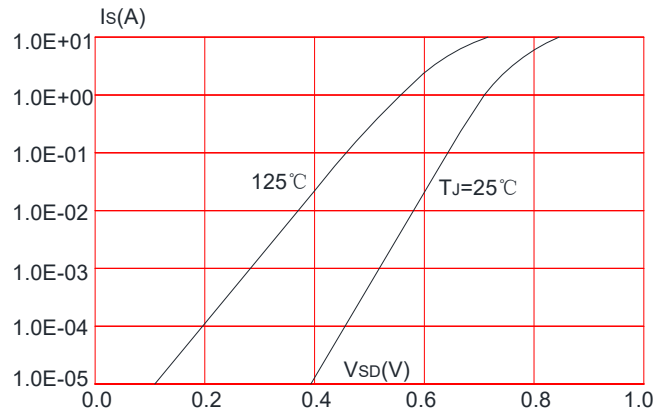


Figure 5: Gate Charge Characteristics

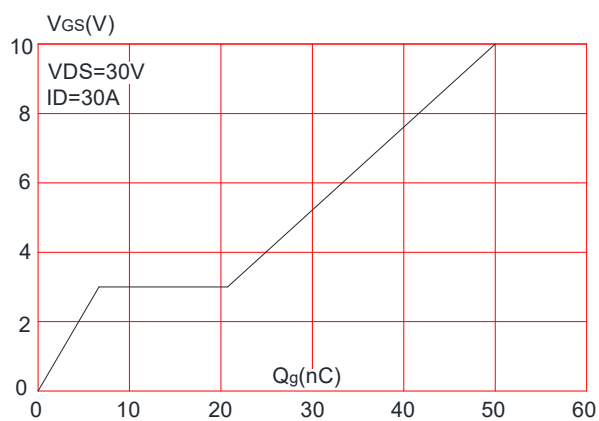
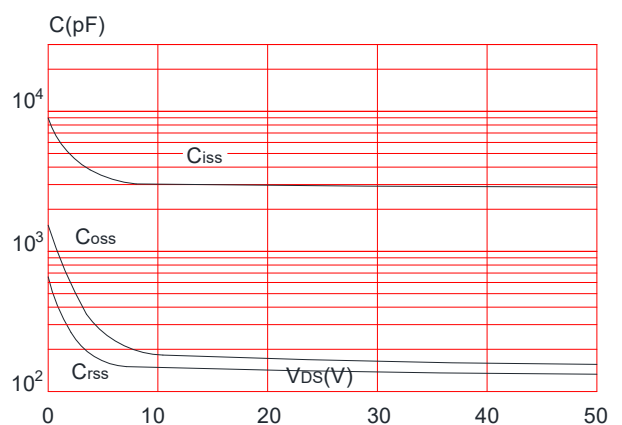


Figure 6: Capacitance Characteristics



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Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

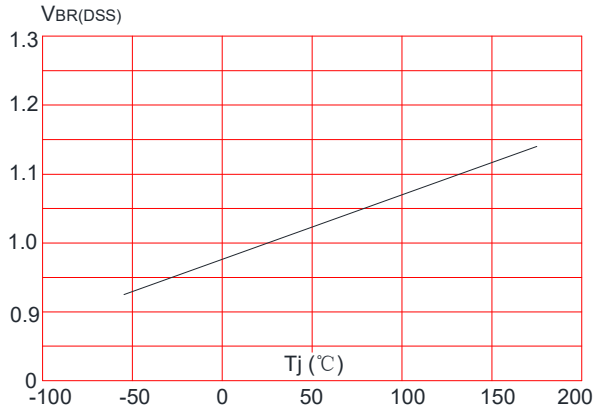


Figure 8: Normalized on Resistance vs. Junction Temperature

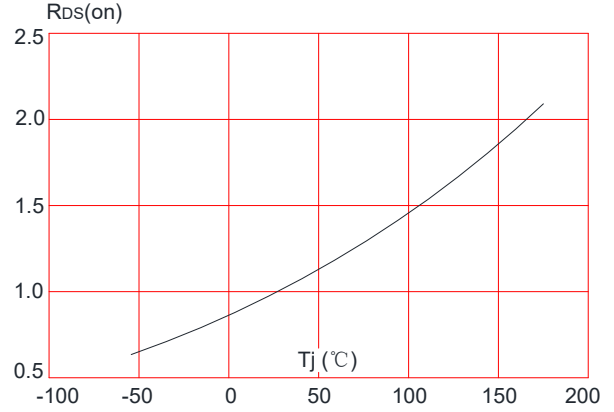


Figure 9: Maximum Safe Operating Area

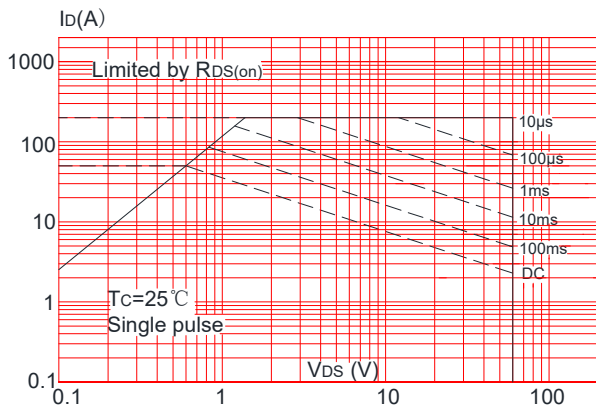


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

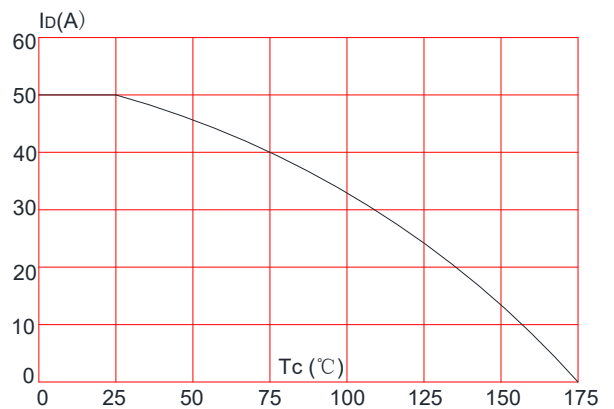
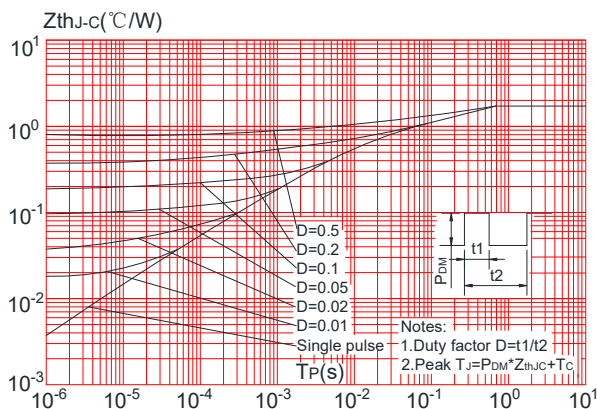


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case



Package Information:TO-251S-3L

UNIT: mm

| SYMBOL | min | nom | max |
|--------|-------|------|-------|
| A | 2.20 | | 2.40 |
| b | 0.50 | | 0.85 |
| C | 0.45 | 0.50 | 0.60 |
| D | 6.50 | | 6.70 |
| D1 | 5.10 | | 5.50 |
| E | 5.9 | | 6.20 |
| e | 2.18 | 2.29 | 2.38 |
| L | 11.00 | | 12.40 |
| L1 | 4.8 | | 5.3 |
| L2 | 3.5 | | 4.2 |

